Atty. Docket No.: R11.12-0813

Appl. No.: 10/829,124

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

First Named Inventor:

Jonathan M. Jongsma et al.

Filing Date
April 21, 2004

2819

Group Art:

U.S. PATENT DOCUMENTS

	iner tial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
X	AA	Re.29,383	09/06/77	Gallatin et al.	137	14	
T	AB	3,096,434	07/02/63	King	235	151	
	AC	3,404,264	10/01/68	Kugler	235	194	
	AD	3,468,164	09/23/69	Sutherland	73	343	
	AE	3,590,370	06/29/71	Fleischer	324	51	
	AF	3,688,190.	08/29/72	Blum	324	61R .	
	AG	3,691,842	09/19/72	Akeley	73	398C	
	AH	3,701,280	10/31/72	Stroman	73	194	
1	AI	3,973,184	08/03/76	Raber	324	51	
	AJ	4,058,975	11/22/77	Gilbert et al.	60	39.28	,
	AK	4,099,413	07/11/78	Ohte et al.	73	359	•
	AK	4,102,199	07/25/78	Talpouras	73	362	
	AL	4,122,719	10/31/78	Carlson et al.	73	342	
	AM	4,250,490	02/10/81	Dahlke	340	870.37	
	AN	4,337,516	06/29/82	Murphy et al.	364	551	
	AO	4,399,824	08/23/83	Davidson	128	736	
	AP	4,517,468	05/14/85	Kemper et al.	290	52	
	AQ	4,528,869	07/16/85	Kubo et al.	74	695	
	AR	4,530,234	07/23/85	Cullick et al.	73	53	
	AS	4,571,689	02/18/86	Hildebrand et al.	364	481	
	AT	4,635,214	01/06/87	Kasai et al.	364	551	
	AU	4,642,782	02/10/87	Kemper et al.	364	550	
	AV	4,644,479	02/17/87	Kemper et al.	364	550	
	AW	4,649,515	03/10/87	Thompson et al.	364	900	
	AX	4,707,796	11/17/87	Calabro et al.	364	552	
1	AY .	9,736,367 /	05/05/88/	Wroblewski et al.	370	85	
EXAMI	NER:	MAIIL	Cauly	DATE CONSIL	DERED:	09/29/0	4

EXAMINER: Initial if/citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Appl. No.: 10/829,124 Atty. Docket No.: R11.12-0813 FORM PTO-1449

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

First Named Inventor:

Jonathan M. Jongsma et al.

Group Art: Filing Date April 21, 2004 2819

•	PIENT	TRADEMART		U.S. PATENT DOCUMENTS		· ·	
	aminer itial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
	BA	4,777,585	10/11/88	Kokawa et al.	364	164	
	Вв	4,807,151	02/21/89	Citron	364	510	
	вс	4,831,564	05/16/89	Suga	364	. 551.01	
	BD	4,841,286	06/20/89	Kummer	340	653	
	BE	4,873,655	10/10/89	Kondraske	364	553	
	BF	4,907,167	03/06/90	Skeirik	364	500	·
	BG	4,924,418	05/08/90	Backman et al.	364	550	
<del></del>	ВН	4,934,196	06/19/90	Romano	73	861.38	
\	BI	4,939,753	07/03/90	Olson	375	107	
7	BJ	4,964,125	10/16/90	Kim	371	15.1	
10	ВК	4,988,990	01/29/91	Warrior	340	25.5	
	BL	4,992,965	02/12/91	Holter et al.	364	551.01	
V	ВМ	5,005,142	04/02/91	Lipchak et al.	364	550	
<del></del>	BN	5,019,760	05/28/91	Chu et al.	318	490	·
	ВО	5,043,862	08/27/91	Takahashi et al.	364	162	
	BP	5,053,815	10/01/91	Wendell	355	208	
•	BQ	5,067,099	11/19/91	McCown et al.	364	550	
	BR	5,081,598	01/14/92	Bellows et al.	364	550	
	BS	5,089,984	02/18/92	Struger et al.	395	650	
	BT	5,098,197	03/24/92	Shepard et al.	374	120	
<del></del>	BU	5,099,436	03/24/92	McCown et al.	364	550	
	BV	5,103,409	04/07/92	Shimizu et al.	364	556	
	BW	5,111,531	05/05/92	Grayson et al.	395	23	
	вх	5,121,467	06/09/92	Skeirik	395	11	
	BY	5)122,7/94	96/16/92	Warrior	340	825.2	}
	<del>~                                    </del>	10/1/	/ //-			01-04	A -

EXAMINER: DATE CONSIDERED: OY / OY / CEXAMINER: PHYLAP if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

EXAMINER:

DATE CONSIDERED:

2819

FORM PTO-1449

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

Jonathan M. Jongsma et al.

Filing Date

Group Art:

April 21, 2004

U.S. PATENT DOCUMENTS

Examiner			Doçument		J.S. PATENT D			Sub	Filing Date
In	iįt	ial	No.	Date	Na	me	Class	Class	If Appropriate
		CA	5,122,976	06/16/92	Bellows et a	al.	364	550	
	1	CB	5,130,936	07/14/92	Sheppard et	al.	364	551.01	
		CC	5,134,574	07/28/92	Beaverstock	et al.	364	551.01	
		ස	5,137,370	08/11/92	McCullock e	t al.	374	173	
		CE	5,142,612	08/25/92	Skeirik		395	11	
		CF	5,143,452	09/01/92	Maxedon et	al.	374	170	
	Π	CG	5,148,378	09/15/92	Shibayama e	t al.	364	551.07	
	Π	CH	5,167,009	11/24/92	Skeirik		395	27	
		CI,	5,175,678	12/29/92	Frerichs et	al.	364	148	
1		CJ	5,193,143	03/09/93	Kaemmerer e	t al.	395	51	
1/1		СК	5,197,114	03/23/93	Skeirik		395	22	
		CL	5,197,328	03/30/93	Fitzgerald		73	168	
		CM	5,212,765	05/18/93	Skeirik		395	11	
		CN	5,214,582	05/25/93	Gray		364	424.03	
		со	5,224,203	06/29/93	Skeirik		395	22	
		CP	5,228,780	07/20/93	Shepard et	al.	374	175	
		CQ	5,235,527	08/10/93	Ogawa et al	•	364	571.05	
		CR	5,265,031	11/23/93	Malczewski	** .	364	497	
		CS	5,265,222	11/23/93	Nishiya et	al.	395	3	
		CT	5,269,311	12/14/93	Kirchner et	al.	128	672	
		CU	5,274,572	12/28/93	O'Neill et	al.	364	550	
		CV	5,282,131	01/25/94	Rudd et al.		364	164	
		CW	5,282,261	01/25/94	Skeirik		395	22	
		СХ	5,293,585	03/08/94	Morita		395	52	
	CY 5,		5,303,181	04/12/94	Stockton		365	96	
EXA	EXAMINER! Mill Jauling					DATE CONSID	ered: &	5/29/6	94.

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

2819

FORM PTO-1449

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

Jonathan M. Jongsma et al.

Filing Date

Group Art:

April 21, 2004

U.S. PATENT DOCUMENTS

Exam Init	iner ial	Document No.	Date	Name ·	Class	Sub Class	Filing Date If Appropriate
1	DA	5,305,230	04/19/94	Matsumoto et al.	364	495	
	∫DB	5,311,421	05/10/94	Nomura et al.	364	157	
	DC	5,317,520	05/31/94	Castle	364	482	
	DD	5,327,357	07/05/94	Feinstein et al.	364	502	
	DE	5,333,240	07/26/94	Matsumoto et al.	395	23	
	DF	5,347,843	09/20/94	Orr et al.	73	3	
	DG	5,349,541	09/20/94	Alexandro, Jr. et al.	364	578	
	DH	5,357,449	10/18/94	Oh	364	551.01	
	DI.	5,361,628	11/08/94	Marko et al.	73	116	
	DJ	5,365,423	11/15/94	Chand	364	140	
7	DK	5,367,612	11/22/94	Bozich et al.	395	22	
	DL	5,384,699	01/24/95	Levy et al.	364	413.13	
	DM	5,386,373	01/31/95	Keeler et al.	364	577	
	DN	5,394,341	02/28/95	Kepner	364	551.01	
	DO	5,394,543	02/28/95	Hill et al.	395	575	
	DP	5,404,064	04/04/95	Mermelstein et al.	310	319	
	DQ	5,408,406	04/18/95	Mathur et al.	364	163	
	DR	5,408,586	04/18/95	Skeirik	395	23	
	DS	5,414,645	05/09/95	Hirano	364	551.01	
	DT	5,419,197	05/30/95	Ogi et al.	73	659	
	DU	5,430,642	07/04/95	Nakajima et al.	364	148	
	DV	5,440,478	08/08/95	Fisher et al.	. 364	188	
	DW	5,442,639	08/15/95	Crowder et al.	371	20.1	
	DX	5,467,355	11/14/95	Umeda et al.	364	571.04	
	DY	5,469,070	11/21/95/	Koluvek	324	713 ,	

EXAMINER: DATE CONSIDERED: 09/9/0 C EXAMINER: /with/n/ if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. FORM PTO-1449

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

Jonathan M. Jongsma et al.

Filing Date Group Art:

April 21, 2004 2819

U.	S.	PA	TENT	DOC	TUMENTS
----	----	----	------	-----	---------

		Examiner Initial		Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
			EA	5,469,156	11/21/95	Kogura	340	870.38	
			ÆΒ	5,469,735	11/28/95	Watanabe	73	118.1	
			EC	5,481,199	01/02/96	Anderson et al.	324	705	
			ED	5,483,387	01/09/96	Bauhahn et al.	359	885	
			EE	5,485,753	01/23/96	Burns et al.	73	720 ·	
			EF	5,486,996	01/23/96	Samad et al.	364	152	
			EG	5,488,697	01/30/96	Kaemmerer et al.	395	51	
			EH	5,489,831	02/06/96	Harris	318	701	
			EI	5,495,769	05/03/96	Broden et al.	73	718	
	•		ЕJ	5,510,799	04/23/96	Maltby et al.	340	870.300	
			EK	5,511,004	04/23/96	Dubost et al.	364	551.01	
<u>,                                    </u>	$\neg$		EK	5,548,528	08/20/96	Keeler et al.	364	497	
			EL	5,561,599	10/01/96	Lu	364	164	
$\prod$			EM	5,570,300	10/29/96	Henry et al.	364	551.01	
₩			EN	5,572,420	11/05/96	Lu	364	153	
			EO	5,573,032	11/12/96	Lenz et al.	137	486	
			EP	5,598,521	01/28/97	Kilgore et al.	395	326	
			EQ	5,600,148	02/04/97	Cole et al.	250	495.1	
			ER	5,623,605	04/22/97	Keshav et al.	395	200.17	
			ES	5,637,802	06/10/97	Frick et al.	73	724	
			ET	5,640,491	06/17/97	Bhat et al.	395	22	
			EU	5,661,668	08/26/97	Yemini et al.	364	550	-
			EV	5,665,899	07/09/97	Willcox	73	1.63	
		EW 5,669,713		5,669,713	09/23/97	Schwartz et al.	374	1	
			EX	5,671,335	09/23/97	Davis et al.	395	23	
	V		EY	5,675,504	10/07/97	Serodes et al.	364	496 /	·
				711/1/	1 6.10.	2222		2/20/0	26.6

EXAMINER: DATE CONSIDERED: 09/29/06.

EXAMINER: Initial of citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Atty. Docket No.: R11.12-0813 Appl. No.: 10/829,124 FORM PTO-1449

## LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

Jonathan M. Jongsma et al.

First Named Inventor:

Filing Date Group Art: April 21, 2004 2819

U.S. PATENT DOCUMENTS

		iner ial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
		FA	5,675,724	10/07/97	Beal et al.	395	182.02	
		r FB	5,680,109	10/21/97	Lowe et al.	340	608	
	1	FC	5,700,090	12/23/97	Eryurek	374	210	
		FD	5,703,575	12/30/97	Kirpatrick	340	870.17	
		FE	5,704,011	12/30/97	Hansen et al.	395	22	
		FF	5,705,978	01/06/98	Frick et al.	340	511	
		FG	5,708,585	01/13/98	Kushion	364	431.061	
		FH	5,710,708	01/20/98	Wiegland	364	470.1	
		FI	5,713,668	02/03/98	Lunghofer et al.	374	179	
$\sqrt{1}$		FJ	5,719,378	02/17/98	Jackson, Jr. et al.	219	497	
/ <u>/ / / / / / / / / / / / / / / / / / </u>		FK	5,741,074	04/21/98	Wang et al.	374	185	
1		FK	5,742,845	04/21/98	Wagner	395	831	
1		FL	5,746,511	05/05/98	Eryurek et al.	374	2	
		FM	5,752,008	05/12/98	Bowling	395	500	-
		FN	5,764,891	06/09/98	Warrior	395	200.2	
		FO	5,781,878	07/14/98	Mizoguchi et al.	701	109	
		FP	5,801,689	09/01/98	Huntsman	345	329	
<u></u>		FQ	5,805,442	09/08/98	Crater et al.	364	138	
		FR	5,828,567	10/27/98	Eryurek et al.	700	79	
<del></del>		FS	5,829,876	11/03/98	Schwartz et al.	374	1	
		FT	5,848,383	12/08/98	Yuuns	702	102	
		FU	5,859,964	01/12/99	Wang et al.	395	185.01	
		FV	5,876,122	03/02/99	Eryurek	374	183	
	T	FW	5,880,376	03/09/99	Sai et al.	73	861.08	
	$\top$	FX	5,887,978	03/30/99	Lunghofer et al.	374	179	
		FY	5, <del>92</del> 3,557	07/13/99	Eidson	364	471.03	

EXAMINER: DATE CONSIDERED: 0/20/Cr

EXAMINER Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

**EXAMINER:** 

DATE CONSIDERED:

Atty. Docket No.: R11.12-0813

Appl. No.: 10/829,124

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

First Named Inventor:

Jonathan M. Jongsma et al.

Filing Date Group Art:

April 21, 2004

2819

U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
1	GA	5,924,086	07/13/99	Mathur et al.	706	25	
1	GB	5,926,778	07/20/99	Pöppel	702	130	
	GC	5,940,290	08/17/99	Dixon	364	138	
	GD	5,956,663	09/21/99	Eryurek et al.	702	183	
	GE	5,970,430	10/19/99	Burns et al:	702	122	_
	GF	6,014,902	01/18/00	Lewis et al.	73	861.12	
	GG	6,016,523	01/18/00	Zimmerman et al.	710	63	
	GH	6,016,706	01/25/00	Yamamoto et al.	9	6	
7	GI	6,017,143	01/25/00	Eryurek et al.	700	51	·
	GJ	6,038,579	03/14/00	Sekine	708	400	
•	GK	6,045,260	04/04/00	Schwartz et al.	374	183	
	GL .	6,047,220	04/04/00	Eryurek et al.	700	28	
	GM	6,047,222	04/04/00	Burns et al.	700	79	
	GN	6,052,655	04/18/00	Kobayashi et al.	702	184	
	GO	6,119,047	09/12/00	Eryurek et al.	700	28	
	GP	6,119,529	07/19/00	Di Marco et al.	73	861.68	
	GQ	6,151,560	11/21/00	Jones	702	58	
	GR	6,192,281	01/20/01	Brown et al.	700	2	
	GS	6,195,591	01/27/01	Nixon et al.	700	2	
	GT	6,199,018	03/06/01	Quist et al.	702	34	
	GÜ	6,236,948	05/22/01	Eck et al.	702	45	
	GV	6,263,487	07/17/01	Stripf et al.	717	1	
	GW	6,298,377	10/02/01	Hartikainen et al.	709	223	
	GX	6,311,136	10/30/01	Henry et al.	702	45	
	GY	6,327,914,	12/11/01/	Dutton	73	861.356	,

EXAMINER: DATE CONSIDERED: 09/9/0C EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449	Atty. Docket No.: R11.12-0813	Appl. No.: 10/829,124		
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor:  Jonathan M. Jongsma et al.			
	Filing Date	Group Art:		
	April 21, 2004	2819		

U.S. PATENT DOCUMENTS

Exam Init		Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
	TA	3,618,592		Stewart	128	2.05R	
	TB	3,855,858	12/24/74	Cushing	73	194 EM	
	TC	4,668,473	05/26/87	Agarwal	422	62	
	TD	4,720,806	01/19/88	Schippers et al.	364	551	
	TE	4,736,763	04/12/88	Britton et al.	137	10	
	TF	4,818,994	04/1989	Orth et al.	340	501	
·	TG	5,089,979	02/18/92	McEachern et al.	364	571.04	
	TH	5,388,465	02/14/95	Okaniwa et al.	73	861.17	
	TI	5,365,787	11/22/94	Hernandez et al.	73	. 660	
	TJ	5,436,705	07/25/95	Raj	355	246	
T = T	TK	5,526,293	06/11/96	Mozumder et al.	. 364	578	
1	TL	5,539,638	07/23/96	Keeler et al.	364	424.03	
	TM	5,560,246	10/01/96	Bottinger et al.	73	861.15	
	TN	5,591,922	01/07/97	Segeral et al.	73	861.04	
	TO	5,608,650	03/04/97	McClendon et al.	364	510	·
	TP	5,633,809	05/27/97	Wissenbach et al.	364	510	
	TQ	5,708,211	01/13/98	Jepson et al.	73	861.04	
	TR	5,710,370	01/20/98	Shanahan et al.	73	1.35	
	TS	5,736,649	04/07/98	Kawasaki et al.	73	861.23	
	тт	5,747,701	05/05/98	Marsh et al.	73	861.23	
	TU	5,817,950	10/06/98	Wiklund et al.	73	861.66	
	TV	5,908,990	06/01/99	Cummings	73	861.22	
	TW	5,936,514	08/10/99	Anderson et al.	340	310.01	
	TX	6,139,180	10/31/00	Usher et al.	374	1	
	TY	6,360,277	03/19/02	Ruckley et al.	09	250	
1	TZ	6,425,03/8	07/23/9/2	Sprecher	710	269	

DATE CONSIDERED:

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449	Atty. Docket No.: R11.12-0813	Appl. No.: 10/829,124		
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor:			
•	Jonathan M. Jongsma et al.			
	Filing Date	Group Art:		
	April 21, 2004	2819		

U.S. PATENT DOCUMENTS

			0.5	PATENT DOCUMENTS	<del></del>	<del></del>	<del></del>
	iner tial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
	на	6,370,448	4/2002	Eryurek et al.	700	282	
	нв	6,519,546	2/2003	Eryurek et al.	702	130	
,	HC	09/257,896	02/25/99	Eryurek et al.	702	183	
	HD	6,397,114	5/2002	Eryurek et al.	700	51	
	HE	6,356,191	3/2002	Kirkpatrick et al.	340	501	
	HF	6,601,005	7/2003	Eryurek et al.	702	104	
	НG	6,505,517	1/2003	Eryurek et al.	73	861.08	
T	нн	6,434,504	8/2002	Eryurek et al.	702	130	
1	ні	6,654,697	11/2003	Eryurek et al.	702	47	
	НJ	6,701,274	3/2004	Eryurek et al.	702	140	
	нк	6,556,145	4/2003	Kirkpatrick et al.	340	870.17	
	HL	09/409,098 /	09/30/99	Eryurek et al.	102	104	
	нм	6,594,603	7/2003	Eryurek et al.	702	104	
	HN	6,539,267	3/2003	Eruyrek et al.	700	51	
	но	6,615,149	9/2003	Wehrs	702	76	
	HP	6,473,710	10/2002	Eryurek	702	133	
	НQ	6,449,574	9/2002	Eryurek et al.	702	99	
	HR	6,532,392	3/2003	Eryurek et al.	700	54	
	HS.	6,611,775	8/2003	Coursolle et al.	702	65	
	нт	09/799,824 _	03/05/01	Rome et al.	324	7/8	
	HU	09/855,179 -	05/14/01	Eryurek et al.	707	183	
	HV	09/852,102 -	05/09/01	Eryurek et al.	702	182	
	HW	2003/0045962	08/30/01	Eryurek et al.	100	127	
	нх	09/972,078 /	10/05/01	Eryurek et al.	700	629	
1	ну	10/635,944	08/9/7/03	Huisenga et al.	435	006	
		11.111	1/1		<del></del>	09/20	0-

EXAMINER: DATE CONSIDERED: 09/79/00000

EXAMINER: thitisl if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

APPLICANT'S INFORMATION

THE STATEMENT

FORM PTO-1449

**EXAMINER:** 

Atty. Docket No.: R11.12-0813

First Named Inventor:

Appl. No.: 10/829,124

LIST OF PATENTS AND PUBLICATIONS FOR

Jonathan M. Jongsma et al.

Group Art: Filing Date 2819 April 21, 2004

FOREIGN PATENT DOCUMENTS

			Document No.	Date	Country	Class	Sub Class	Translation Yes No
	1	IA	WO 94/25933	11/10/94	WIPO			<b>X</b> .
	1	IB	WO 96/11389	04/18/96	WIPO			х
		IC	WO 96/12993	05/02/96	WIPO			х
		ID	WO 96/39617	12/12/96	WIPO			х
		IE	WO 97/21157	06/12/97	WIPO			х
		IF	WO 97/25603	07/17/97	WIPO			х
	T	IG	WO 98/06024	02/12/98	WIPO			х
-		IH	WO 98/13677	04/1998	WIPO			<b>X</b> .
		II	WO 98/20469	05/14/98	WIPO			х
		IJ	WO 98/39718	09/11/98	WIPO			х , , , ,
1		IK	WO 99/19782	04/22/99	WIPO			х
1,1		IL	WO 00/55700	09/21/00	WIPO			х
-//		IM	WO 00/70531	11/23/00	WIPO		!	х
		IN	0 122 622 A1	10/24/84	EPO			х
1		10	0 413 814 A1	02/27/91	EPO			х
V		IP	0 487 419 A2	05/27/92	EPO			х
		IQ	0 512 794 A2	11/11/92	EPO			х
,		IR	0 594 227 A1	04/27/94	EPO			х
		IS	0 624 847 A1	11/17/94	EPO		-	X (Abstract)
		. IT	0 644 470 A2	03/22/95	EPO			х
		IU	0 807 804 A2	19/11/97	EPO	,		х
	_	IV	0 825 506 A2	07/14/97	EPO			х
		IW	0 827 096 A2	09/01/97	EPO			х
		IX	0 838 768 A2	09/24/97	EPO			х
1		IY	1 022 626 A2	07/26/00	EPO			х
7		IZ	1 058 093 A1	05/29/99	EPO .		/	(Abstract Only

EXAMINER: DATE CONSIDERED: DATE CONSIDER copy of this form with next communication to applicant.

DATE CONSIDERED:

Appl. No.: 10/829,124 Atty. Docket No.: FORM PTO-1449 R11.12-0813 First Named Inventor: ATENTS AND PUBLICATIONS FOR CANT'S INFORMATION URE STATEMENT Jonathan M. Jongsma et al. Group Art: Filing Date April 21, 2004 2819

FOREIGN PATENT DOCUMENTS

	_		·		FAIBNI DOCUMENTO			
			Document No.	Date	Country	Class	Sub Class	Translation Yes No
		JA	58-129316	08/02/83	Japan			X (Abstract)
	Λ.	JВ	59-116811	07/05/84	Japan			X (Abstract)
		JC	59-163520	09/14/84	Japan			(Abstract Only)
		JD	59-211196	11/29/84	Japan			Title and Claim
		JE	59-211896	11/30/84	Japan			X (Abstract)
		JF	60-000507	01/05/85	Japan			X (Abstract)
		JG	60-76619	05/01/85	Japan			X (Abstract)
		ЛН	60-131495	07/13/85	Japan			X (Abstract)
1		JI	60-174915	09/09/85	Japan			(Abstract Only)
0		JК	62-30915	02/09/87	Japan			X (Abstract)
		JL	64-72699	03/17/89	Japan			X (Abstract)
		<b>J</b> M	64-01914	01/06/89	Japan		•	X (Abstract)
		JN	2-05105	01/10/90	Japan			X (Abstract)
		JO	3-229124	10/11/91	Japan			(Abstract Only)
		JP	5-122768	05/18/93	Japan			X (Abstract)
		JQ	06242192	09/02/94	Japan			X (Abstract)
		JR	7-063586	03/10/95	Japan			X (Abstract)
		JS	07234988	09/05/95	Japan			X (Abstract)
		JT	8-054923	02/27/96	Japan			X (Abstract)
		ஶ	8-102241	04/16/96	Japan			(Abstract Only)
		JV	8-136386	05/31/96	Japan			X (Abstract)
		JW	8-166309	06/25/96	Japan			X (Abstract)
		JХ	8-247076	09/24/96	Japan			(Abstract Only)
		JΥ	8-313466	11/29/96	Japan			(Abstract Only)
7		JZ	2712625	10/31/97	Japan		,	х

DATE CONSIDERED: 09/29/06

Typitial if citation considered, whether or not citation is in conformance with EXAMINER: MPEP 609; draw line through citation if not in conformance and not considered. copy of this form with next communication to applicant.

EXAMINER:

Atty. Docket No.: R11.12-0813

Appl. No.: 10/829,124

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

First Named Inventor:

Jonathan M. Jongsma et al. Group Art: Filing Date 2819 April 21, 2004

EODE TON	ייע <i>ו</i> דער עס	DOCTIMENTS

	NT 8 790	O	FOREIGN	PATENT DOCUMENTS		<del></del>	<del></del>
		Document No.	Date	Country	Class	Sub Class	Translation Yes No
7	КА	2712701	10/31/97	Japan			х
1	КВ	2753592	03/06/98	Japan			х
	кс	07225530	05/1998	Japan			(Abstract Only)
	κο	10-232170	09/02/98	Japan	,		х
	KE	11-083575	03/26/99	Japan			(Abstract Only)
	KF	DE 32 13 866 A1	10/27/83	Germany			(Abstract Only)
	KG	DE 35 40 204 C1	09/25/86	Germany			X (Abstract)
	кн	DE 40 08 560 A1	09/20/90	Germany			X (Abstract)
,•	ĸJ	DE 43 43 747	06/1994	Germany			(Abstract Only)
	KK	DE 44 33 593 A1	06/01/95	Germany			X (Abstract)
	KL	DE 195 02 499 A1	08/01/96	Germany			X (Abstract)
	КМ	DE 296 00 609 U1	03/27/97	Germany			х
	KN	DE 197 04 694 A1	08/14/97	Germany			(Abstract Only)
	ко	DE 19930660-A1	07/02/99	Germany			(Abstract Only)
	KP	DE 199 05 071	08/10/00	Germany			(Abstract Only)
	KQ	DE 299 17 651 U1	12/14/00	Germany			x
	KR	DE 100 36 971 A1	02/28/02	Germany			(Abstract Only)
	KS	928,704	06/12/63	United Kingdom			х
	KT	1 534 280	11/29/78	United Kingdom			х
	KU	1 534 288	11/29/78	United Kingdom			х
	кv	2 310 346 A	08/20/97	United Kingdom			х
	KW	2 342 453 A	04/12/00	United Kingdom			х
	кх	2 347 232 A	08/30/00	United Kingdom			х
	KY	2 302 514	09/24/76	France			(Abstract Only)
V	KZ	2 334 827	07/08/77	France		, ,	(Abstract Only)

DATE CONSIDERED: EXAMINER!

EXAMINER: Thitial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

		γ	neet 13 of 24			
FORM PTO-1		Atty. Docket No.: R11.12-0813	Appl. No.: 10/829,124			
·	LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor:				
	A MOV CO	Jonathan M. Jongsma e	t al.			
( JUL 3	· ~ ш .	Filing Date	Group Art:			
SETEN SIA		April 21, 2004	2819			
TA	OTHER ART (Including Author, Title, Date,	Pertinent Pages Etc )				
LA	"A TCP\IP Tutorial" by, Socolofsky et al., 8 pp. 1-23.		January 1991			
LB	"Approval Standards For Explosionproof Elect Requirements", Factory Mutual Research, Cl.	trical Equipment Genera No. 3615, March 1989,	nl pp. 1-34.			
LC	"Approval Standard Intrinsically Safe Appara In Class I, II, and III, Division 1 Hazardon Mutual Research, Cl. No. 3610, October 1988	us (Classified) Locatio	paratus For Use ons", Factory			
КО	"Automation On-line" by, Phillips et al., P	lant Services, July 199	7, pp. 41-45.			
LE	"Climb to New Heights by Controlling your Plal., Intech, August 1998, pp. 50-51.	LCs Over the Internet"	by, Phillips et			
· LF	"CompProcessor For Piezoresistive Sensors" I	MCA Technologies Inc. (	MCA7707), pp.			
IG	"Ethernet emerges as viable, inexpensive fid Engineering, December 1997, p. 23-29.	eldbus", Paul G. Schrei	er, Personal			
LH	"Ethernet Rules Closed-loop System" by, Eid: 42.	son et al., Intech, Jun	ne 1998, pp. 39-			
V LI	"Fieldbus Standard for Use in Industrial Con Specification and Service Definition", ISA-	ntrol Systems Part 2: F S50.02-1992, pp. 1-93.	hysical Layer			
LJ	"Fieldbus Standard for Use in Industrial Con Service Definition", ISA-S50.02-1997, Part	ntrol Systems Part 3: E 3, August 1997, pp. 1-1	oata Link .59.			
LK	"Fieldbus Standard For Use in Industrial Cor Protocol Specification, ISA-S50.02-1997, Par					
LL	"Fieldbus Support For Process Analysis" by, Blevins et al., Fisher-Rosemount Systems, Inc., 1995, pp. 121-128.					
LM.	"Fieldbus Technical Overview Understanding Fisher-Rosemount, 1998, pp. 1-23.	FOUNDATION™ fieldbus t	echnology",			
LN	"Hypertext Transfer Protocol HTTP/1.0" by 1996, pp. 1-54.	y, Berners-Lee et al.,	MIT/LCS, May			
ro	"Infranets, Intranets, and the Internet" by March 1997, pp. 46-50.	, Pradip Madan, Echelon	Corp, Sensors,			
LP	"Internet Technology Adoption into Automatic Business, pp. 1-5.		Automation			
EXAMINER!	MIM Jayline DATE CO	onsidered: 03/29/6	(C)			

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

EXAMINER (

Atty. Docket No.: R11.12-0813

Appl. No.: 10/829,124

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT First Named Inventor:

Jonathan M. Jongsma et	al.
Filing Date	Group Art:
April 21, 2004	2819

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) "Internet Protocol Darpa Internet Program Protocol Specification" by, Enformation MA Sciences Institute, University of Southern California, RFC 791, September 1981, pp. 1-43. MPA "Introduction to Emit", emWare, Inc., 1997, pp. 1-22. "Introduction to the Internet Protocols" by, Charles L. Hedrick, Computer Science Facilities Group, Rutgers University, October 3, 1988, pp. 1-97. "Is There A Future For Ethernet in Industrial Control?", Miclot et al., Plant MD Engineering, October 1988, pp. 44-46, 48, 50. ME LFM/SIMA Internet Remote Diagnostics Research Project Summary Report, Stanford University, January 23, 1997, pp. 1-6. "Managing Devices with the Web" by, Howard et al., Byte, September 1997,\pp. 45 MF MG "Modular Microkernel Lyinks GUI And Browser For Embedded Web Devices" by, Tom Williams, pp. 1-2. Un Kh ma)n MH "PC Software Gets Its Edge From Windows, Components, and the Internet", Wayne Labs, I&CS, March 1997, pp. 23-32. Proceedings Sensor Expo, Aneheim, California, Produced by Expocon Managemnet MI Associates, Inc., April 1996, pp. 9-21. MJ Proceedings Sensor Expo, Boston, Massachuttes, Produced by Expocon Management Associates, Inc., May 1997, pp. 1-416. MK "Smart Sensor Network of the Future" by, Jay Warrior, Sensors, March 1997, pp. 40-45. ML"The Embedded Web Site" by, John R. Hines, IEEE Spectrum, September 1996, p. 23. MM "Transmission Control Protocol: Darpa Internet Program Protocol Specification" Information Sciences Institute, September 1981, pp. 1-69. MN "On-Line Statistical Process Control for a Glass Tank Ingredient Scale," by R.A. Weisman, IFAC real Time Programming, 1985, pgs. 29-38. "The Performance of Control Charts for Monitoring Process Variation," by C. Lowry MO et al., COMMUN. STATIS. - SIMULA., 1995, pgs. 409-437. "A Knowledge-Based Approach for Detection and Diagnosis of Out-Of-Control Events in Manufacturing Processes, by P. Love et al., IEEE, 1989, pgs. 736-741.

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

DATE CONSIDERED: U

Appl. No.: 10/829,124 Atty. Docket No.: FORM PTO-1449 R11.12-0813 First Named Inventor: LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT Jonathan M. Jongsma et al. Group Art: Filing Date 2819 April 21, 2004 OTHER ART (Including Author, Pertinent Pages, Etc.) "Advanced Engine Diagnostics Using Universal Process Modeling", by P. O'Sullivan, NA Presented at the 1996 SAE Conference on Future Transportation Technology, pgs. 1-"Parallel, Fault-Tolerant Control and Diagnostics System for Feedwater Regulation in PWRS, by E. Eryurek et al., Proceedings of the American Power Conference "Programmable Hardware Architectures for Sensor Validation", by M.P. Henry et NC al., Control Eng. Practice, Vol. 4, No. 10., pgs. 1339-1354, (1996). "Sensor Validation for Power Plants Using Adaptive Backpropagation Neural Network, " IEEE Transactions on Nuclear Science, Vol. 37, No. 2, by E. Eryurek et al. April 1990, pgs. 1040-1047. "Signal Processing, Data Handling and Communications: The Case for Measurement Validation", by M.P. Henry, Department of Engineering Science, Oxford University, "Smart Temperature Measurement in the '90s", by T. Kerlin et al., C&I, (1990). NF "Software-Based Fault-Tolerant Control Design for Improved Power Plant NG Operation," IEEE/IFAC Joint Symposium on Computer-Aided Control System Design, March 7-9, 1994 pgs. 585-590. "A Standard Interface for Self-Validating Sensors, by M.P. Henry et al., Report No. QUEL 1884/91, (1991). "Taking Full Advantage of Smart Transmitter Technology Now," by G. Orrison, NT Control Engineering, Vol. 42, No. 1, January 1995. "Using Artificial Neural Networks to Identify Nachear Power Plant States," by NJ Israel E. Alguindigue et al., pgs. 1-4. "Application of Neural Computing Paradigms for Signal Validation, " by B. Upadhyaya et al., Department of Nuclear Engineering, pgs. 1-18. "Application of Neural Networks for Sensor Validation and Plant Monitoring," by NL B. Upadhyaya et al., Nuclear Technology, Vol. 97, No. 2, Feb. 1992 pgs. 170-176 "Automated Generation of Nonlinear System Characterization for Sensor Failure Detection, "by B.R. Upadhyaya et al., ISA, 1989 pgs. 269-274. "In Situ Calibration of Nuclear Plant Platinum Resistance Thermometers Using NN Johnson Noise Methods, " EPRI, June 1983. "Johnson Noise Thermometer for High Radiation and High-Temperature Environm/n," NO by L. Oakes et al., Fifth Symposium on Space Nuclear Power Systems, January pgs. 2-23. "Development of a Resistance Thermometer For Use Up to 1600°C", by M.J. et\_al., CAL LAB, July/August 1996, pgs. 38-41. DATE CONSIDERED: EXAMINER/ Initial if citation considered, whether or not citation is in confe MPEP 609; draw line through citation if not in conformance and not consider copy of this form with next communication to applicant.

Sheet 16 of 24

FORM	PTO-	1449	Atty. Docket No.: Appl. No.: 10/829,124				
		LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor:				
1			Jonathan M. Jongsma et	al.			
	-41	20 11	Filing Date	Group Art:			
		~ m [5]	April 21, 2004	2819			
	RADEN	SOVEWHER ART (Including Author, Title, Date,	Pertinent Pages, Etc.)	-			
1	OA	"Survey, Applications, And Prospects of John et al., Electrical Engineering Department,  "Noise Thermometry for Industrial and Metro."	nson Noise Thermometry,' 1981 pgs. 2-11.	by T. Blalock			
	OB	"Noise Thermometry for Industrial and Metro by H. Brixy et al., 7th International Sympo	logical Applications at osium on Temperature, 19	KFA Julich,"			
	oc	"Johnson Noise Power Thermometer and its App Measurement," by T.V. Blalock et al., Americ 1249-1259.					
	OD	"Field-based Architecture is Based on Open S by P. Cleaveland, <u>I&amp;CS</u> , August 1996, pgs. 73	Systems, Improves Plant 3-74.	Performance",			
	OE	"Tuned-Circuit Dual-Mode Johnson Noise There April 1992.	mometers," by R.L. Shepa	ard et al.,			
	OF		"Tuned-Circuit Johnson Noise Thermometry," by Michael Roberts et al., 7 <sup>th</sup> Symposium on Space Nuclear Power Systems, January 1990.				
VI	OG	"Smart Field Devices Provide New Process Date Mark Boland, <u>I&amp;CS</u> , November 1994, pgs. 45-5		cibility," by			
	ОН	"Wavelet Analysis of Vibration, Part I: The Vibration and Acoustics, Vol. 116, October		Journal of			
	OI	"Wavelet Analysis of Vibration, Part 2: Wave of Vibration and Acoustics, Vol. 116, October	elet Maps," by D.E. New er 1994, pgs. 417-425.	land, <u>Journal</u>			
	OJ	"Development of a Long-Life, High-Reliabilithermometer," by R.L. Shepard et al., <u>ISA</u> ,	ty Remotely Operated Joh 1991, pgs. 77-84.	nnson Noise			
	OK	"Application of Johnson Noise Thermometry to Roberts et al., Presented at the 6th Sympos. January 9-12, 1989.	o Space Nuclear Reactors ium on Space Nuclear Por	s," by M.J. wer Systems,			
	OL	"A Decade of Progress in High Temperature Jo Blalock et al., American Institute of Physic	ohnson Noise Thermometry cs, 1982 pgs. 1219-1223	y," by T.V.			
	ОМ	"Sensor and Device Diagnostics for Predictive and Proactive Maintenance", by Boynton, A Paper Presented at the Electric Power Research Institute - Fossil Plant Maintenance Conference in Baltimore, Maryland, July 29-August 1, 1996, 50-1 - 50-6.					
	ON	"Detection of Hot Spots in Thin Metal Films Noise Measurement System," by G.H. Massiha Technologies in the Southeast, Vol. 3 of 3,	et al., Energy and Info	rmation			
1	00	"Detecting Blockage in Process Connections Transmitters" by E. Taya et al., SICE, 199	of Differential Pressure 5, pgs. 1605-1608.	3			

EXAMINER: Injuly Af citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FO	RM I	PTO-14	149	Atty. Docket No.: R11.12-0813	Appl. No.: 10/829,124			
		L	IST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor:				
/		01,		Jonathan M. Jongsma et	al.			
16	JU/	2.0	m	Filing Date	Group Art:			
ATEN		~ 200		April 21, 2004	. 2819			
100	BAN	AHK OF	OTHER ART (Including Author, Title, Date,	Pertinent Pages, Etc.)				
		ARKOT	"Development and Application of Neural Netwo Diagnostics," by B.R. Upadhyaya et al., Pro Decision and Control, 1990, pgs. 3277-3282.	ork Algorithms For Proce				
		PB	"A Fault-Tolerant Interface for Self-Valida Colloquium, pgs. 3/1-3/2 (November 1990).	ting Sensors", by M.P. H	lenry,			
		PC	"Fuzzy Logic and Artificial Neural Networks Applications," by R.C. Berkan et al., Procedented Light Walnut .					
		PD	"Fuzzy Logic and Neural Network Application al., International Journal of Approximate R					
1	,	PE	"Keynote Paper: Hardware Compilation-A New Digital Systems-Applied to Sensor Validation Practice, Vol. 3, No. 7., pgs. 907-924, (19	n", by M.P. Henry, Cont				
V		PF	"The Implications of Digital Communications al., Report No. QUEL 1912/92, (1992).	on Sensor Validation",	by M. Henry et			
		PG	"In-Situ Response Time Testing of Thermocoupaper No. 89-0056, pgs. 587-593, (1989).	ples", <u>ISA</u> , by H.M. Hash	nemian et al.,			
		PH	"An Integrated Architecture For Signal Valid Upadhyaya et al., Third IEEE International August 24-26, 1988, pgs. 1-6.					
		PI	"Integration of Multiple Signal Validation Upadhyaya et al., Department of Nuclear Eng	Modules for Sensor Monit ineering, July 8, 1990,	coring," by B. pgs. 1-6.			
		PJ	PJ "Intelligent Behaviour for Self-Validating Sensors", by M.P. Henry, Advances In Measurement, pgs. 1-7, (May 1990).					
		PK	"Measurement of the Temperature Fluctuation in a Resistor Generating 1/F Fluctuation," by S. Hashiguchi, <u>Japanese Journal of Applied Physics</u> , Vol. 22, No. 5, Part 2, May 1983, pgs. L284-L286.					
		PL	"Check of Semiconductor Thermal Resistance Elements by the Method of Noise Thermometry", by A. B. Kisilevskii et al., <u>Measurement Techniques</u> , Vol. 25, No. 3, March 1982, New York, USA, pgs. 244-246.					
		PM	"Neural Networks for Sensor Validation and International Fast Reactor Safety Meeting,	Plant Monitoring," by B. August 12-16, 1990, pgs.	Upadhyaya, 2-10.			
		PN	"Neural Networks for Sensor Validation and 1992.	Plantwide Monitoring," b	oy E. Eryurek,			
_\		РО	"A New Method of Johnson Noise Thermometry" Instrum., Voly 45, No. 2, (February 1974) p	, by C.J. Borkowski et a gs. 151-162.	al., Rev. Sci.			
EX	EXAMINER: MI// Vaulus DATE CONSIDERED: 09/29/04							

EXAMINER: Intial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

		•								
			·S	heet 18 of 24						
FORM	PTO-14	449	Atty. Docket No.: R11.12-0813	Appl. No.: 10/829,124						
	L	IST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT OF THE PROPERTY OF THE PROPER	First Named Inventor:							
		1 28m =	Jonathan M. Jongsma e	t al.						
		₩. <sup>→</sup> .\\	Filing Date	Group Art:						
		RADEMARK OFFICE	April 21, 2004	2819						
_		OTHER ART (Including Author, Title, Date,	Pertinent Pages, Etc.)							
	QA	"Thermocouple Continuity Checker," IBM Tech No. 5, pages 1954 (October 1977).	nical Disclosure Bullet	in, Vol. 20,						
	QB	"A Self-Validating Thermocouple," Janice C-Systems Technology, Vol. 5, No. 2, pp. 239-	Y et al., IEEE Transact 53 (March 1997).	ions on Control						
	QC	Instrument Engineers' Handbook, Chapter IV by T.J. Claggett, pp. 266-333 (1982).	<pre>Instrument Engineers' Handbook, Chapter IV entitled "Temperature Measurements," by T.J. Claggett, pp. 266-333 (1982).</pre>							
	QD	"emWare's Releases EMIT 3.0, Allowing Manufa Enable Devices Royalty Free," 3 pages, PR No.	acturers to Internet an ewswire (November 4, 19	d Network 98).						
	QE	Warrior, J., "The IEEE P1451.1 Object Model Sensors and Actuators," pp. 1-14, Rosemount	Network Independent In Inc. (1997).	terfaces for						
	QF	Warrior, J., "The Collision Between the Web Conference Workshop on Embedded Web Technol	and Plant Floor Automa ogy, Santa Clara, CA (A	tion," 6 <sup>th</sup> . WWW pril 7, 1997).						
	QG	Microsoft Press Computer Dictionary, 3rd Edi	tion, page 124. Car	cunknown						
اوا	QH	"Internal Statistical Quality Control for Qual	uality Monitoring Instr	uments", by P.						
	QI	Web Pages from www.triant.com (3 pgs.).	date unknown							
	QЛ	"Statistical Process Control (Practice Guide America, 1995, pgs. 1-58 and 169-204.	e Series Book)", <u>Instru</u>	ment Society of						
	QK	"Time-Frequency Analysis of Transient Pressure Signals for a Mechanical Heart Valve Cavitation Study," <u>ASAIO Journal</u> , by Alex A. Yu et al., Vol. 44, No. 5, pgs. M475-M479, (September - October 1998).								
-	QL	"Transient Pressure Signals in Mechanical Hal., pgs. M555-M561 (undated)	eart Valve Caviation,"	by Z.J. Wu et						
	QM	"Caviation in Pumps, Pipes and Valves," Propgs. 47 and 49 (January 1990).	cess Engineering, by Dr	. Ronald Young,						
	QN	"Quantification of Heart Valve Cavitation B Measurements," <u>Advances in Bioengineering 1</u> Vol. 28, pgs. 297-298 (November 6-11, 1994)	994, by Laura A. Garris	ressure on et al., BED-						
	QO	"Monitoring and Diagnosis of Cavitation in Distribution," Hydroaccoustic Facilities, I Techniques, NCA-Vol. 10, pgs. 31-36 (1991).	Pumps and Valves Using nstrumentation, and Exp	the Wigner erimental						
1	QP	"Developing Predictive Models for Cavitation	n Erosion," Codes and S	tandards in A						

EXAMINER: DATE CONSIDERED: 09/29/00.

EXAMINER: thitial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

DATE CONSIDERED: 69

Global Environment PVP-Vol. 259, pgs. 189-192 (1993).

Atty. Docket No.: R11.12-0813

Appl. No.: 10/829,124

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

First Named Inventor:

Jonathan M. Jongsma et al. Group Art: 2819

Filing Date April 21, 2004

		OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)
	RA	"Self-Diagnosing Intelligent Motors: A Key Enabler for Next Generation Manufacturing System," by Fred M. Discenzo et al., pgs. 3/1-3/4 (1999).
	RB	"A Microcomputer-Based Instrument for Applications in Platinum Resistance Thermomety," by H. Rosemary Taylor and Hector A. Navarro, Journal of Physics E. Scientific Instrument, Vol. 16, No. 11, pp. 1100-1104 (1983).
	RC .	"Experience in Using Estelle for the Specification and Verification of a Fieldbus Protocol: FIP," by Barretto et al., Computer Networking, pp. 295-304 (1990).
	RD	"Computer Simulation of H1 Field Bus Transmission," by Utsumi et al., Advances in Instrumentation and Control, Vol. 46, Part 2, pp. 1815-1827 (1991).
	RE	"Progress in Fieldbus Developments for Measuring and Control Application," by A. Schwaier, Sensor and Acuators, pp. 115-119 (1991).
	RF	"Ein Emulationssystem zur Leistungsanalyse von Feldbussystemen, Teil 1," by R. Hoyer, pp. 335-336 (1991).
	RG	"Simulatore Integrato: Controllo su bus di campo," by Barabino et al., Automazione e Strumentazione, pp. 85-91 (October 1993).
	RH	"Ein Modulares, verteiltes Diagnose-Expertensystem für die Fehlerdiagnose in lokalen Netzen," by Jürgen M. Schröder, pp. 557-565 (1990).
	RI	"Fault Diagnosis of Fieldbus Systems," by Jürgen Quade, pp. 577-581 (10/92).
	ŖJ	"Ziele und Anwendungen von Feldbussystemen," by T. Pfeifer et al., pp. 549-557 (10/87).
	RK	"PROFIBUS Infrastructure Measures," by Tilo Pfeifer et al., pp. 416-419 (8/91).
	RL	"Simulation the Time Behaviour of Fieldbus Systems," by O. Schnelle, pp. 440-442 (1991).
	RM	"Modélisation et simulation d'un bus de terrain: FIP," by Song et al, pp. 5-9 (undated).
	RN	"Field Bus Networks for Automation Systems Containing Intelligent Functional Unites," by W. Kriesel et al., pp. 486-489 (1987).
	RO	"Field Buses for Process Interconnection with Digital Control Systems," Tecnología, pp. 141-147 (1990).
V	RP	"Decentralised Systems with Real-Time Field Bus," Netzwerke, Jg. Nr.3 v. 14.3, 4 pages (1990).
_1_	·	

EXAMINER: DATE CONSIDERED: 08/29/00

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Appl. No.: 10/829,124 Atty. Docket No.: R11.12-0813 FORM PTO-1449 First Named Inventor: LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMEN Jonathan M. Jongsma et al. Filing Date Group Art: April 21, 2004 2819

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

			Olibic Act (Including Addict, 11010, 2000, 1010110111111111111111111
$\bigwedge$	s	SA	"Process Measurement and Analysis," by Liptak et al., Instrument Engineers' Handbook, Third Edition, pp. 528-530, (1995).
	s	В	"Improving Dynamic Performance of Temperature Sensors With Fuzzy Control Techniques," by Wang Lei et al., pp. 872-873 (1992).
	s	SC	"Microsoft Press Computer Dictionary" 2nd Edition, 1994, Microsoft Press. p. 156
	s	SD	Copy of International Search Report from Application Number PCT/US01/40791 with international filing date of May 22, 2001.
	S	SE	Copy of International Search Report from Application Number PCT/US01/40782 with international filing date of May 22, 2001.
	s	F	Copy of International Search Report from Application Number PCT/02/14560 with international filing date of May 8, 2002.
	2	ZG	Copy of International Search Report from Application Number PCT/US02/14934 with international filing date of May 8, 2002.
	S	эн	"On-Line Tool Condition Monitoring System With Wavelet Fuzzy Neural Network," by Li Xiaoli et al., pp. 271-276 (1997).
	s	SI	"Optimal Design of the Coils of An Electromagnetic Flow Meter," by Michalski, A. et al., IEEE Transactions on Magnetics, Vol. 34, Issue 5, Part 1, pp. 2563-2566 (1998).
	S	ij	"Magnetic Fluid Flow Meter for Gases," Popa, N.C., IEEE Transactions on Magnetics, Vol. 30, Issue 2, Part 1-2, pp. 936-938 (1993).
	S	SK	"New Approach to A Main Error Estimation for Primary Transducer of Electromagnetic Flow Meter," by Michalski, A., IEEE Instrumentation and Measurement Technology Conference Proceedings, Vol. 2, pp. 1093-1097 (1998).
·	٤	SL	"Additional Information From Flowmeters Via Signal Analysis," by Amadi-Echendu, J.E. et al., IEEE Instrumentation and Measurement Technology Conference Record, Vol. 7, pp. 187-193 (1990).
	2	SM	Copy of International Search Report from Application Number PCT/US02/06606 with international filing date of March 5, 2002.
1	/ 5	SN	Copy of International Search Report from Application Number PCT/US02/30465 with international filing date of September 25, 2002.
4	5	50	
<del>-</del>	S	SP	
	5	SQ.	
	9	SR.	

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Atty. Docket No.: R11.12-0813

Appl. No.: 10/829,124

LIST OF PATENTS AND PUBLICATIONS FOR

ODINION STATEMENT

First Named Inventor:

Jonathan M. Jongsma et al.

Filing Date Group Art:

April 21, 2004

2819

U.S. PATENT DOCUMENTS

Examiner Docume		Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
1	TA	4,630,265	12/15/86	Sexton	370	85	
	TB	5,434,774	07/18/95	Seberger	364	172	
	TC	5,555,190	09/10/96	Derby et al.	364	510	
	TD	6,023,399	02/08/00	Kogure	361	23	
11	TE	6,209,048	03/27/01	Wolff	. 710	62	
7	TF	6,272,438	08/07/01	Cunningham et al.	702	56	
$\neg \vdash$	TG	6,370,448	04/09/02	Eryurek	700	282	
	TH	6,377,859	04/23/02	Brown et al.	700	79	
	TI	6,473,656	10/29/02	Langels et al.	700	17	
	TJ	6,317,701	11/13/01	Pyostsia et al.	702	188	
	TK	6,307,483	10/23/01	Westfield et al.	340	870.11	<u>.</u>
·	TL	6,061,603	05/09/00	Papadopoulos et al.	700	83	
7	TM	2002/0013629	01/31/02	Nixon et al.			

FOREIGN PATENT DOCUMENTS

•			Document No.	Date	Country	Class	Sub Class	Translation Yes No
	۱ /	TN	WO 00/41050	07/13/00	WIPO	2	-	х
	1	то	WO 01/77766	10/18/01	WIPO			Х .
	1	TP	WO 02/27418	04/04/02	WIPO			х

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	OTHER ART	(Including Auth	or, Title, Date, Pe	rtinent Pages, E	te.)	
TQ						
TR						
TS					$\overline{}$	
TT						
TU		2			×1 _	
EXAMINER:	11/11/4	ulue	DATE CON	SIDERED: 09/29	7/04	

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449

Atty. Docket No.: Appl. No.: R11.12-0813

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCOURE STATEMENT

JUL 28 2004 CS

Filing Date Group Art: April 21, 2004

April 21, 2004

2819

TT /		DOCUME	ATT C

Examiner Initial		Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
V	UA	5,216,226	06/01/93	Miyoshi	219	497	
	UΒ	5,481,200	01/02/96	Voegele et al.	324	718	
	טכ	5,629,870	05/13/97	Farag et al.	364	551.01	
	Œ	5,654,869	08/05/97	Ohi et al.	361	540	
	UE.	6,405,099	6/11/02	Nagai et al.	700	159	
,	UF	2002/0145568	10/10/02	Winter	343	701	
	υG	4,926,364	5/15/90	Brotherton	364	581	
V	UH	5,340,271	8/23/94	Freeman et al.	415	1	
	UI	5,410,495	4/25/95	Ramamurthi	364	511.05	
$\Box$	ໜ	5,764,539	6/9/98	Rani	364	557	
T	υĸ	5,790,413	8/4/98	Bartusiak et al.	364	485	
	ஶ	6,480,793	11/12/02	Martin	702	45	
	UM	2003/0045962	3/6/03	Eryurek et al.	700	128	
	UN	2003/0033040	2/13/03	Billings	700	97	
	υo	4,540,468	9/10/85	Genco et al.	162	49	
	UP	5,150,289	9/22/92	Badavas	364	154	
	ŪQ	5,672,247	9/30/97	Pangalos et al.	162	65	
1	UR	4,758,308	7/19/88	Carr	162	263	

## FOREIGN PATENT DOCUMENTS

			Document No.	Date	Country	Class	Sub Class	Translation Yes No
	ر الد	US	06-248224	10/14/94	Japan			х
	,V	UT	999950	11/16/76	Canada			х
	1	บบ	WO 98/14855	04/09/98	WIPO			х

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

"What is a weighted moving average?", <u>DAU STAT REFRESHER</u>, <a href="http://cne.grau.edu/modules/dau/stat/mvavgs/wma\_bdy.html">http://cne.grau.edu/modules/dau/stat/mvavgs/wma\_bdy.html</a>. (1995).

EXAMINER: DATE CONSIDERED: 03/29/04

EXAMINER: Traitial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Atty. Docket No.: Appl. No.: **FORM PTO-1449** R11.12-0813 10/829,124 First Named Inventor: LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT Jonathan M. Jongsma et al. Filing Date Group Art: JUL 2 8 2004 April 21, 2004 2819 U.S. PATENT DOCUMENTS Sub Filing Date Examiner Class Class If Appropriate Date Name Initial 8/11/87 Furuse 364 558 WA 4,686,638 49.2 73 WB 6,182,501 2/6/01 Furuse et al. WC 10/1998 Warrior et al. 700 7 5,825,664 Burns et al. 702 182 WD 02/15/00 6,026,352 700 WE 6,094,600 07/25/00 Sharpe, Jr. et al. 19 WF 9/2003 Longsdorf et al. 10/675,014 WG 10/744,809 12/2003 Brown et al. Begemann et al. 162 198 WH 6,179,964 1/2001 11/1974 235 151 WT 3,849,637 Caruso et al. 4/1976 Ottenstein 137 12 WJ. 3,952,759 2/1981 340 870.3 WK 4,249,164 Tivv 870.37 4,279,013 7/1981 Dahlke 340 WL WΜ 11/1983 Cronin eta 1. 364 510 4,417,312 8/1989 Eaton-Williams 340 588 WN 4,853,693 FOREIGN PATENT DOCUMENTS Sub Translation Country Class Class Yes No Document No. Date X WO 08-114638 5/1996 Japan WO OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) "Statistics Glossary: Time Series Data", by Easton et al., http://www.stats.gla.ac.uk/steps/glossary/time\_series.html, 9/1997. WS "The Indicators Story", Sustainable Seattle, pgs 55-59, 1998. "Detecting Regimes in Temperature Time Series", by Clemins et al., Artificial WT Neural Networks in Engineering, Proceedings, pages 727-732, 2001. "Re: Digital Filter-Moving Average", The Math Forumn, WU http://mathforum/org/disquss/sci.math/a/t/177212, 9/28/98. **EXAMINER:** DATE CONSIDERED: () citation considered, whether or not citation is in/conformance with Initial if MPEP 609; draw line through citation if not in conformance and not considered. copy of this form with next communication to applicant.

Atty. Docket No.: Appl. No.: FORM PTO-1449 R11.12-0813 10/829,124 LIST OF PATENTS AND PUBLICATIONS FOR First Named Inventor: APPLICANT'S INFORMATION DISCLOSURE STATEMENT Jonathan M. Jongsma et al. Filing Date Group Art: April 21, 2004 2819 U.S. PATENT DOCUMENTS Filing Date Examiner Document No. Sub Initial Date Name Class Class If Appropriate WV 5,434,774 7/1995 Seberger 364 172 WW 5,469,749 11/1995 Shimada et al. 73 861.47 10/1997 Keeler et al. 364 431.03 WX 5,682,317 395 500 WY 5,752,008 5/1998 Bowling WZ 6,023,399 2/2000 Kogure 361 23 Sheffer 219 121.83 XA 6,072,150 6/2000 Ghorashi et al. XB 6,112,131 8/2000 700 142 XC 6,199,018 3/2001 Quist et al. 702 34 XD 2/2002 Behr et al. 700 2 6,347,252 ΧE 6,370,448 4/2002 Ervurek 700 19 XF 6,397,114 5/2002 Eryurek et al. 700 32 XG OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) U.S. Patent Application Serial No. 10/733,558, filed December 11, 2003. MX XN U.S. Patent Application Serial No. 10/635,944, filed August 7, 2003. U.S. Patent Application Serial No. 10/719,163, filed November 21, 2003. XO FIELDVUE® Instruments, "Improving Safety Instrumented System Reliability," ΧP Emerson Process Management, cover sheet, Technology and Innovation in Process Control, 8 pages, 2002 "Functional Safety and Safety Integrity Levels", Applications Note, April 2002, ΧQ pgs. 1-6. Article entitled "Safety Field" 2600T Pressure Transmitter Family", ABB Instrumentation Spar 29 pages. dall un DATE CONSIDERED: 09 EXAMINER: EXAMINER: Initial/if citation considered, whether or not citation is in conformance with Waw line through citation if not in conformance and not considered. Include MPEP 609; copy of this form with next communication to applicant.